

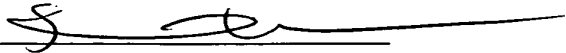
Application No.: 09/735,840

Docket No.: M1912.0020/P020

Consideration and allowance of the application are earnestly solicited.

Dated: March 24, 2004

Respectfully submitted,

By 

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Attachments



PTO/SB/08a/b (05-03)
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Substitute for form 1449/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)			Complete if Known		
			Application Number	09/735,840	
			Filing Date	December 13, 2000	
			First Named Inventor	Takeo Nozaki	
			Art Unit	N/A	
			Examiner Name	Not Yet Assigned	
Sheet	1	of	1	Attorney Docket Number	M1912.0020/P020

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U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)				
	BA	JP-4-181105	06-29-1992			
	BB	JP-11-205823	07-30-1999			
	BC	JP-11-304453	11-05-1999			
	BD	JP-4-350776	12-04-1992			

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	CA	Japanese Office Action issued June 24, 2003 (w/ English translation of relevant portion)	

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APPLICANT'S ART CITATION <small>(Use several sheets if necessary)</small>								Application 09/735,840				OFGS File No P/1912-20			
								Applicant NOZAKI, T.							
								Filing Date 12/13/00				Group Art Unit 2877			
U.S. PATENT DOCUMENTS															
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	Document Number							Date	Country	Class	Sub-class	Translation			
												Yes	No		
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	0	9	3	0	4	9	9	7/1999	EUROPE			n/a			
	0	8	9	9	5	5	9	3/1999	EUROPE			n/a			
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								Applicant Takeo NOZAKI											
								Filing Date December 13, 2000						Group Art Unit __					
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Examiner Initial	Document Number							Date	Name	Class	Sub-class	Filing Date If Appropriate							
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	Document Number							Date	Country	Class	Sub-class	Translation							
												Yes No							
		3	5	0	7	7	6	1992	Japan			in Spec , page 4							
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)																			
	Reference material: Yoshihiko Nomura et al. "Sub-pixel Expression of Edge Position Measurement and Error Analysis, Electronic Information Communication Association Paper, D-11, Vol. J73-D-11, No. 9, pp 1458-1467, September 1990 -- in Specification, page 4																		
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